

Notice of References Cited	Application/Control No. 10/501,383		Applicant(s)/Patent Under Reexamination KANEGAE ET AL.	
	Examiner HENOK G. HEYI		Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0177914 A1	11-2002	Chase, Tim	700/94
*	B	US-2002/0164152 A1	11-2002	Kato et al.	386/95
*	C	US-6,839,059 B1	01-2005	Anderson et al.	345/501
*	D	US-6,985,411 B2	01-2006	Kanegae et al.	369/30.04
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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